## Search Notes



| Application/Control | No. |  |
|---------------------|-----|--|
|                     |     |  |

10682542

Applicant(s)/Patent Under Reexamination

WEE ET AL.

Examiner

X. L Bautista

Art Unit 2179

| SFA | RCHFD |  |
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| SEARCHED |                                     |           |          |  |
|----------|-------------------------------------|-----------|----------|--|
| Class    | Subclass                            | Date      | Examiner |  |
| 715      | 700,716,717,719,753,764,771,773,863 | 2/10/2008 | XB       |  |
| 715      | 205                                 |           |          |  |
| 345      | 156,173                             |           |          |  |
| 348      | 143,155,159                         |           |          |  |

## SEARCH NOTES

| Search Notes | Date      | Examiner |
|--------------|-----------|----------|
| EAST Search  | 2/10/2008 | XB       |

## INTERFERENCE SEARCH

| Class | Subclass | Date | Examiner |
|-------|----------|------|----------|
|       |          |      |          |

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